Applicant(s)/Patent Under Application/Control No. Reexamination 09/839,209 TANAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2834 Tran N. Nguyen **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY Χ US-6,333,582 12-2001 310/263 Α Asao et al. В US-С US-US-D US-Ε F US-G US-Н US-US-1 US-J US-Κ US-L Μ US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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